**ON Semiconductor** 

Is Now

# Onsemi

To learn more about onsemi<sup>™</sup>, please visit our website at <u>www.onsemi.com</u>

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product factures, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and asfety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or by customer's technical experts. onsemi products and actal performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiari

# **Bus Buffer with 3-State Output**

The NL17SG126 MiniGate<sup>™</sup> is an advanced high–speed CMOS Bus Buffer with 3–State Output in ultra–small footprint.

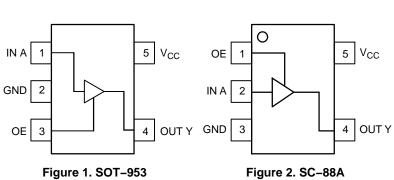
The NL17SG126 input structures provides protection when voltages up to 4.6 V are applied.

#### Features

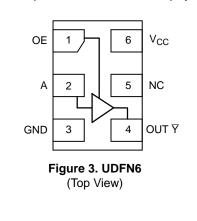
- Wide Operating  $V_{CC}$  Range: 0.9 V to 3.6 V
- High Speed:  $t_{PD} = 2.3$  ns (Typ) at  $V_{CC} = 3.0$  V,  $C_L = 15$  pF
- Low Power Dissipation:  $I_{CC} = 0.5 \ \mu A$  (Max) at  $T_A = 25^{\circ}C$
- 4.6 V Overvoltage Tolerant (OVT) Input Pins
- Ultra-Small Packages

(Top Thru View)

• These are Pb–Free and Halide–Free Devices



(Top View)



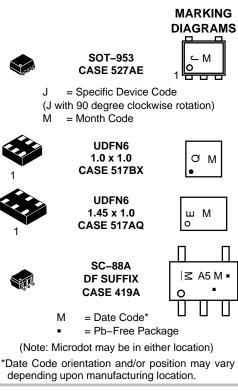






## **ON Semiconductor®**

http://onsemi.com



PIN ASSIGNMENT						
	SOT-953 SC-88A UDFN6					
1	IN A	OE	OE			
2	GND	IN A	IN A			
3	OE	GND	GND			
4	OUT Y	OUT Y	OUT Y			
5	V <sub>CC</sub>	V <sub>CC</sub>	NC			
6			V <sub>CC</sub>			

## FUNCTION TABLE

A Input	OE Input	Y Output
x	L	Z
L	н	L
н	н	н

## ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

#### MAXIMUM RATINGS

Symbol	Pa	rameter	Value	Unit
V <sub>CC</sub>	DC Supply Voltage		–0.5 to +5.5	V
V <sub>IN</sub>	DC Input Voltage		-0.5 to +4.6	V
V <sub>OUT</sub>	DC Output Voltage		–0.5 to V <sub>CC</sub> +0.5	V
I <sub>IK</sub>	DC Input Diode Current	V <sub>IN</sub> < GND	-20	mA
Ι <sub>ΟΚ</sub>	DC Output Diode Current	V <sub>OUT</sub> < GND	-20	mA
I <sub>OUT</sub>	DC Output Source/Sink Current		±20	mA
I <sub>CC</sub>	DC Supply Current per Supply Pin		±20	mA
I <sub>GND</sub>	DC Ground Current per Ground Pin		±20	mA
T <sub>STG</sub>	Storage Temperature Range		-65 to +150	°C
ΤL	Lead Temperature, 1 mm from Case for	10 Seconds	260	°C
Τ <sub>J</sub>	Junction Temperature Under Bias		+150	°C
MSL	Moisture Sensitivity		Level 1	
F <sub>R</sub>	Flammability Rating	Oxygen Index: 28 to 34	UL 94 V–0 @ 0.125 in	
V <sub>ESD</sub>	ESD Withstand Voltage	Human Body Model (Note 2) Machine Model (Note 3)	>2000 >100	V
I <sub>LATCHUP</sub>	Latchup Performance	Above $V_{CC}$ and Below GND at 125°C (Note 4)	±100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2-ounce copper trace with no air flow.
 Tested to EIA/JESD22-A114-A.

3. Tested to EIA/JESD22-A115-A.

4. Tested to EIA/JESD78.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Characteristics	Min	Max	Unit
V <sub>CC</sub>	Positive DC Supply Voltage	0.9	3.6	V
V <sub>IN</sub>	Digital Input Voltage	0.0	3.6	V
V <sub>OUT</sub>	Output Voltage Output at High or Low State Power–Down Mode (V <sub>CC</sub> = 0 V)	0.0 0.0	V <sub>CC</sub> 3.6	V
T <sub>A</sub>	Operating Temperature Range	-55	+125	°C
$\Delta t / \Delta V$	Input Transition Rise or Fail Rate $$V_{CC}$$ = 3.3 V $\pm$ 0.3 V	0	10	ns/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### DC ELECTRICAL CHARACTERISTICS

					T <sub>A</sub> =	25°C		∖ = o +125°C	
Symbol Paramete	Parameter	Parameter C	meter Conditions	V <sub>CC</sub> (V)	Min	Max	Min	Max	Unit
V <sub>IH</sub>	High-Level			0.9	V <sub>CC</sub>		V <sub>CC</sub>		V
	Input Voltage			1.1 to 1.3	0.7xV <sub>CC</sub>		0.7xV <sub>CC</sub>		
	voltage			1.4 to 1.6	0.65xV <sub>CC</sub>		0.65xV <sub>CC</sub>		
				1.65 to 1.95	0.65xV <sub>CC</sub>		0.65xV <sub>CC</sub>		1
				2.3 to 2.7	1.7		1.7		1
				3.0 to 3.6	2.0		2.0		1
VIL	Low–Level Input			0.9		GND		GND	V
	Voltage			1.1 to 1.3		0.3xV <sub>CC</sub>		0.3xV <sub>CC</sub>	1
				1.4 to 1.6		0.35xV <sub>CC</sub>		0.35xV <sub>CC</sub>	1
				1.65 to 1.95		0.35xV <sub>CC</sub>		0.35xV <sub>CC</sub>	1
				2.3 to 2.7		0.7		0.7	1
				3.0 to 3.6		0.8		0.8	1
V <sub>OH</sub>	High-Level	V <sub>IN</sub> =	I <sub>OH</sub> = -20 μA	0.9	0.75		0.75		V
	Output Voltage	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -0.3 mA	1.1 to 1.3	0.75xV <sub>CC</sub>		0.75xV <sub>CC</sub>		1
			I <sub>OH</sub> = -1.7 mA	1.4 to 1.6	0.75xV <sub>CC</sub>		0.75xV <sub>CC</sub>		1
			I <sub>OH</sub> = -3.0 mA	1.65 to 1.95	V <sub>CC</sub> -0.45		V <sub>CC</sub> -0.4 5		
			I <sub>OH</sub> = -4.0 mA	2.3 to 2.7	2.07		2.07		1
			I <sub>OH</sub> = -8.0 mA	3.0 to 3.6	2.75		2.75		
V <sub>OL</sub>	Low-Level	V <sub>IN</sub> =	I <sub>OL</sub> = 20 μA	0.9		0.1		0.1	V
	Output Voltage	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 0.3 mA	1.1 to 1.3		0.25xV <sub>CC</sub>		0.25xV <sub>CC</sub>	
			I <sub>OL</sub> = 1.7 mA	1.4 to 1.6		0.25xV <sub>CC</sub>		0.25xV <sub>CC</sub>	
			I <sub>OL</sub> = 3.0 mA	1.65 to 1.95		0.45		0.45	
			I <sub>OL</sub> = 4.0 mA	2.3 to 2.7		0.4		0.4	
			I <sub>OL</sub> = 8.0 mA	3.0 to 3.6		0.4		0.4	
I <sub>IN</sub>	Input Leakage Current	0 ≤	V <sub>IN</sub> ≤ 3.6 V	0 to 3.6		±0.1		±1.0	μA
I <sub>CC</sub>	Quiescent Supply Current	V <sub>IN</sub> =	V <sub>CC</sub> or GND	3.6		1.0		10.0	μΑ
I <sub>OZ</sub>	3–State Output Leakage Current	V <sub>IN</sub> V <sub>OUT</sub>	= V <sub>IH</sub> or V <sub>IL</sub> <sub>F</sub> = 0 to 3.6 V	0.9 to 3.6		1.0		10.0	μΑ

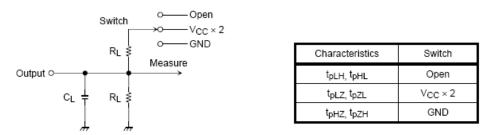
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

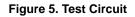
#### AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3.0 \text{ ns}$ )

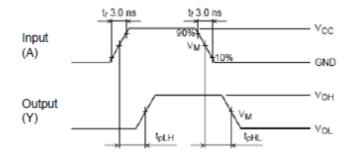
					T <sub>A</sub> = 25 °C	₄ = 25 °C		∖ = o +125°C		
Symbol	Parameter	Test Condition	V <sub>CC</sub> (V)	Min	Тур	Max	Min	Мах	Uni	
t <sub>PLH</sub> ,	Propagation Delay,	C <sub>L</sub> = 10 pF,	0.9	-	11.3	13.6	-	15.9	ns	
t <sub>PHL</sub>	A to Y	$R_L = 1 M\Omega$	1.1 to 1.3	-	8.3	10.4	-	12.8		
			1.4 to 1.6	-	5.0	8.5	-	10.0		
			1.65 to 1.95	-	4.0	6.2	-	6.7		
			2.3 to 2.7	-	2.6	3.9	-	4.4		
			3.0 to 3.6	-	2.1	3.1	-	3.7		
		C <sub>L</sub> = 15 pF,	0.9	-	12.6	14.7	-	17.0	ns	
		$R_L = 1 M\Omega$	1.1 to 1.3	-	9.6	11.5	-	15.2		
			1.4 to 1.6	-	5.6	9.3	-	11.2		
			1.65 to 1.95	-	4.5	6.9	-	7.1		
			2.3 to 2.7	-	2.9	4.4	-	5.0		
			3.0 to 3.6	-	2.4	3.4	-	3.9		
		C <sub>L</sub> = 30 pF,	0.9	-	14.5	16.3	-	19.6	ns	
		$R_L = 1 M\Omega$	1.1 to 1.3	-	11.3	13.6	-	17.5		
				1.4 to 1.6	-	8.2	13.1	-	15.9	
			1.65 to 1.95	-	6	9.2	-	9.6		
			2.3 to 2.7	-	4	5.7	-	6.1		
			3.0 to 3.6	-	3.3	4.4	-	4.8		
t <sub>PZH</sub> ,	Output Enable Time,	C <sub>L</sub> = 10 pF;							ns	
t <sub>PZL</sub>	OE to Y	$R_L = 100 \text{ k}\Omega$	0.9	-	11.0	13.3	-	15.8		
		$R_L = 5 k\Omega$	1.1 to 1.3	-	8.4	10.9	-	13.0		
		$R_L = 5 k\Omega$	1.4 to 1.6	-	5.3	7.8	-	8.3		
		$R_L = 5 k\Omega$	1.65 to 1.95	-	3.9	5.5	-	5.9		
		$R_L = 5 k\Omega$	2.3 to 2.7	-	2.5	3.5	-	3.8	1	
		$R_L = 5 k\Omega$	3.0 to 3.6	-	2.1	2.7	-	3		
		C <sub>L</sub> = 15 pF;							ns	
		$R_L = 100 \text{ k}\Omega$	0.9	-	12.0	14.8	-	17.0		
		$R_L = 5 k\Omega$	1.1 to 1.3	-	9.0	11.7	-	13.8	1	
		$R_L = 5 k\Omega$	1.4 to 1.6	-	5.9	8.9	-	11		
		$R_L = 5 k\Omega$	1.65 to 1.95	-	4.4	6.3	-	6.5		
		$R_L = 5 k\Omega$	2.3 to 2.7	-	2.9	3.9	-	4.2		
		$R_L = 5 k\Omega$	3.0 to 3.6	-	2.3	3	-	3.3		
		C <sub>L</sub> = 30 pF;							ns	
		$R_L = 100 \text{ k}\Omega$	0.9	-	13.0	15.2	-	18.3		
		$R_L = 5 k\Omega$	1.1 to 1.3	-	10.0	13.1	-	15.2		
		$R_L = 5 k\Omega$	1.4 to 1.6	-	8.3	12.2	-	13.7		
		$R_L = 5 k\Omega$	1.65 to 1.95	-	6.1	8.6	-	9.7		
		$R_L = 5 k\Omega$	2.3 to 2.7	-	3.8	5	-	5.5		
		$R_L = 5 k\Omega$	3.0 to 3.6	_	2.9	3.8	-	4.2	1	

				T <sub>A</sub> = 25 °C			T <sub>A</sub> = −55°C to +125°C		
Symbol	Parameter	Test Condition	V <sub>CC</sub> (V)	Min	Тур	Max	Min	Max	Unit
t <sub>PHZ</sub> ,	Output Disable Time,	C <sub>L</sub> = 10 pF;							ns
t <sub>PLZ</sub>	OE to Y	R <sub>L</sub> = 100 kΩ	0.9	-	100.4	-	-	-	1
		$R_L = 5 k\Omega$	1.1 to 1.3	-	9.1	14.4	-	22.4	1
		$R_L = 5 k\Omega$	1.4 to 1.6	-	7.1	9.1	-	10.4	1
		$R_L = 5 k\Omega$	1.65 to 1.95	-	6.5	8.3	-	9	1
		$R_L = 5 k\Omega$	2.3 to 2.7	-	5.8	7.3	-	8.8	1
		$R_L = 5 k\Omega$	3.0 to 3.6	-	5.4	6.9	-	7.6	1
		C <sub>L</sub> = 15 pF;							ns
		R <sub>L</sub> = 100 kΩ	0.9	-	122.2	-	-	-	1
		$R_L = 5 k\Omega$	1.1 to 1.3	-	9.8	15.3	-	25.1	1
		$R_L = 5 k\Omega$	1.4 to 1.6	-	7.8	9.8	-	11.3	1
		$R_L = 5 k\Omega$	1.65 to 1.95	-	7.2	9.2	-	10.6	1
		$R_L = 5 k\Omega$	2.3 to 2.7	-	7	8.2	-	10.3	1
		$R_L = 5 k\Omega$	3.0 to 3.6	-	6.6	7.7	-	9.5	1
		C <sub>L</sub> = 30 pF;							ns
		R <sub>L</sub> = 100 kΩ	0.9	-	217.1	_	-	-	1
		$R_L = 5 k\Omega$	1.1 to 1.3	-	13.2	19.6	-	31.9	1
		$R_L = 5 k\Omega$	1.4 to 1.6	-	12.2	13.5	-	14.9	1
		$R_L = 5 k\Omega$	1.65 to 1.95	-	11.4	12.7	-	13.9	1
		$R_L = 5 \ k\Omega$	2.3 to 2.7	-	11.3	12.2	-	13.5	1
		$R_L = 5 \ k\Omega$	3.0 to 3.6	_	10.2	11.5	-	12.9	1
C <sub>IN</sub>	Input Capacitance		0 to 3.6		3	-	-	-	pF
CO	Output Capacitance	V <sub>O</sub> = GND	0		3	-	-	-	pF
C <sub>PD</sub>	Power Dissipation Capacitance (Note 5)	f = 10 MHz	0.9 to 3.6	_	4	-	_	_	pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
5. C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I<sub>CC(OPR)</sub> = C<sub>PD</sub> • V<sub>CC</sub> • f<sub>in</sub> + I<sub>CC</sub>. C<sub>PD</sub> is used to determine the no–load dynamic power consumption; P<sub>D</sub> = C<sub>PD</sub> • V<sub>CC</sub><sup>2</sup> • f<sub>in</sub> + I<sub>CC</sub> • V<sub>CC</sub>.









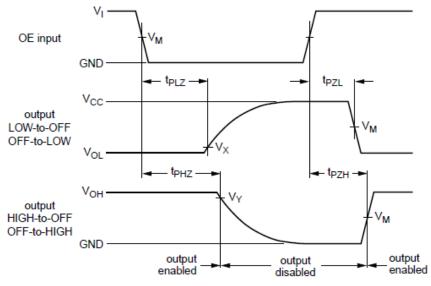


Figure 7.  $t_{PLZ}$ ,  $t_{PHZ}$ ,  $t_{PZH}$ ,  $t_{PZL}$  Waveforms

	V <sub>CC</sub>					
Unit	$3.3 \pm 0.3 \text{ V}$	$2.5\pm0.2~\textrm{V}$	1.8 ± 0.15 V	1.5 ± 0.1 V	1.2 ± 0.1 V	0.9 V
VM	V <sub>CC</sub> / 2	V <sub>CC</sub> / 2	V <sub>CC</sub> / 2	V <sub>CC</sub> / 2	V <sub>CC</sub> / 2	V <sub>CC</sub> / 2
$V_{X}$	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	V <sub>OL</sub> + 0.1 V	V <sub>OL</sub> + 0.1 V	V <sub>OL</sub> + 0.1 V	V <sub>OL</sub> + 0.1 V
$V_{Y}$	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.1 V	V <sub>OH</sub> – 0.1 V	V <sub>OH</sub> – 0.1 V

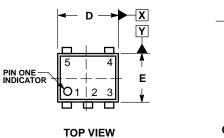
#### **ORDERING INFORMATION**

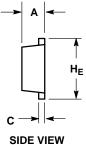
Device	Package	Shipping <sup>†</sup>
NL17SG126P5T5G	SOT-953 (Pb-Free)	8000 / Tape & Reel
NL17SG126P5T6G	SOT–953 (Pb–Free)	8000 / Tape & Reel
NL17SG126DFT2G	SC-88A (Pb-Free)	3000 / Tape & Reel
NL17SG126AMUTCG*	UDFN6 1.45x1 mm (Pb-Free)	3000 / Tape & Reel
NL17SG126CMUTCG*	UDFN6 1x1 mm (Pb-Free)	3000 / Tape & Reel

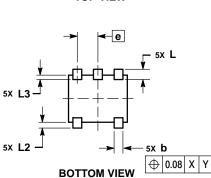
For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
\*In Development

#### PACKAGE DIMENSIONS

SOT-953 CASE 527AE ISSUE E



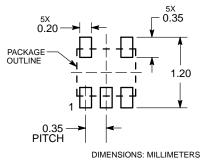




NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

FLASH, PROTRUSIONS, OR G							
	MIL	MILLIMETERS					
DIM	MIN	NOM	MAX				
Α	0.34	0.37	0.40				
b	0.10	0.15	0.20				
С	0.07	0.12	0.17				
D	0.95	1.00	1.05				
Е	0.75	0.80	0.85				
е		0.35 BS	С				
HE	0.95	1.00	1.05				
L	0.175 REF						
L2	0.05	0.10	0.15				
L3			0.15				

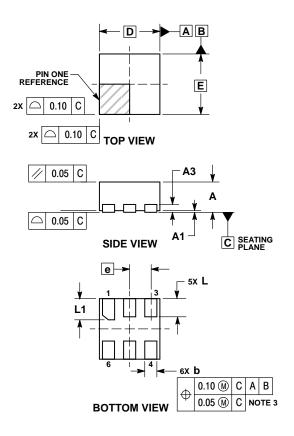
#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

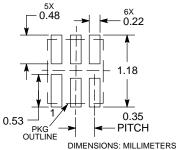
UDFN6 1.0x1.0, 0.35P CASE 517BX ISSUE O



- NOTES:
   DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
   CONTROLLING DIMENSION: MILLIMETERS.
   DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
   PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

BURRS AND MOLD FLASH.						
	MILLIN	IETERS				
DIM	MIN					
Α	0.45	0.55				
A1	0.00	0.05				
A3	0.13	REF				
b	0.12	0.22				
D	1.00	BSC				
Е	1.00	BSC				
е	0.35					
L	0.25	0.35				
L1	0.30	0.40				

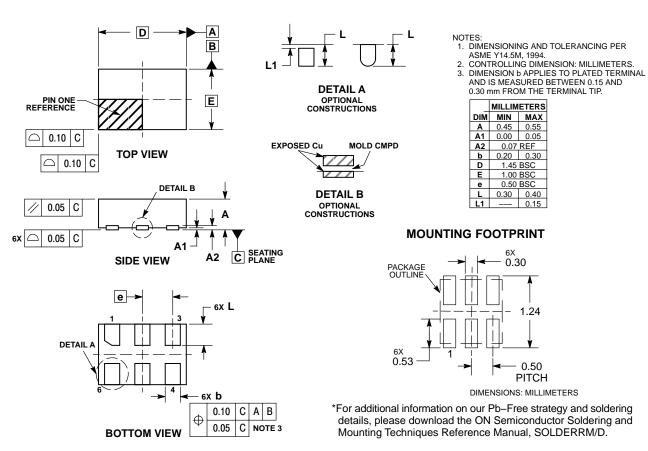
RECOMMENDED **SOLDERING FOOTPRINT\*** 



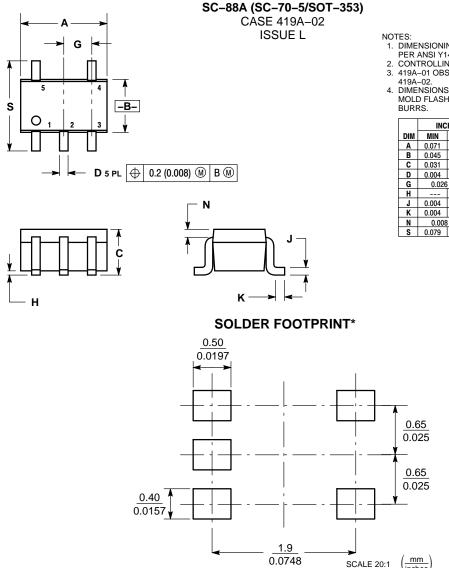
\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

UDFN6 1.45x1.0, 0.5P CASE 517AQ ISSUE O



#### PACKAGE DIMENSIONS



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

MiniGate is a trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

ON Semiconductor and the unage are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent–Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and eventors and reasonable attornow the density and ching fore program in use doing the property. expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

DIMENSIONING AND TOLERANCING

PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

419A–01 OBSOLETE. NEW STANDARD 419A–02.

4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.071	0.087	1.80	2.20
В	0.045	0.053	1.15	1.35
С	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026 BSC		0.65 BSC	
Н		0.004		0.10
J	0.004	0.010	0.10	0.25
Κ	0.004	0.012	0.10	0.30
Ν	0.008 REF		0.20 REF	
s	0.079	0.087	2.00	2.20

## **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Buffers & Line Drivers category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below :

LXV200-024SW 74AUP2G34FW3-7 HEF4043BP PI74FCT3244L MC74HCT365ADTR2G Le87401NQC Le87402MQC 028192B 042140C 051117G 070519XB NL17SZ07P5T5G NLU1GT126AMUTCG 74AUP1G17FW5-7 74LVC2G17FW4-7 CD4502BE 5962-8982101PA 5962-9052201PA 74LVC1G125FW4-7 NL17SH17P5T5G NL17SH125P5T5G NLV37WZ07USG RHRXH162244K1 74AUP1G34FW5-7 74AUP1G07FW5-7 74LVC2G126RA3-7 NLX2G17CMUTCG 74LVCE1G125FZ4-7 Le87501NQC 74AUP1G126FW5-7 TC74HC4050AP(F) 74LVCE1G07FZ4-7 NLX3G16DMUTCG NLX2G06AMUTCG NLVVHC1G50DFT2G NLU2G17AMUTCG LE87100NQC LE87290YQC LE87290YQCT LE87511NQC LE87511NQCT LE87557NQC LE87557NQCT LE87614MQC LE87614MQCT 74AUP1G125FW5-7 NLU2G16CMUTCG MC74LCX244MN2TWG NLV74VHC125DTR2G NL17SG126DFT2G